

PSMN017-80PS

N-channel 80 V 17 mΩ standard level MOSFET in TO220

Rev. 01 — 11 March 2010

Objective data sheet

1. Product profile

1.1 General description

Standard level N-channel MOSFET in TO220 package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for standard level gate drive sources

1.3 Applications

- DC-to-DC converters
- Load switching
- Motor control
- Server power supplies

1.4 Quick reference data

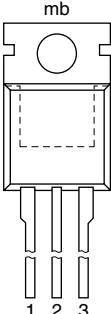
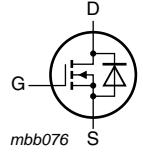
Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25^\circ\text{C}; T_j \leq 175^\circ\text{C}$	-	-	80	V
I_D	drain current	$T_{mb} = 25^\circ\text{C}; V_{GS} = 10\text{ V};$ see Figure 1	-	-	50	A
P_{tot}	total power dissipation	$T_{mb} = 25^\circ\text{C};$ see Figure 2	-	-	103	W
T_j	junction temperature		-55	-	175	°C
Dynamic characteristics						
Q_{GD}	gate-drain charge	$V_{GS} = 10\text{ V}; I_D = 25\text{ A};$	-	6.3	-	nC
$Q_{G(tot)}$	total gate charge	$V_{DS} = 40\text{ V};$ see Figure 14 and 15	-	26.5	-	nC
Static characteristics						
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10\text{ V}; I_D = 10\text{ A};$ $T_j = 100^\circ\text{C};$ see Figure 12	-	-	29	mΩ
		$V_{GS} = 10\text{ V}; I_D = 10\text{ A};$ $T_j = 25^\circ\text{C};$ see Figure 13	-	13.7	17	mΩ



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain		
3	S	source		
mb	D	mounting base; connected to drain		

SOT78 (TO-220AB)

3. Ordering information

Table 3. Ordering information

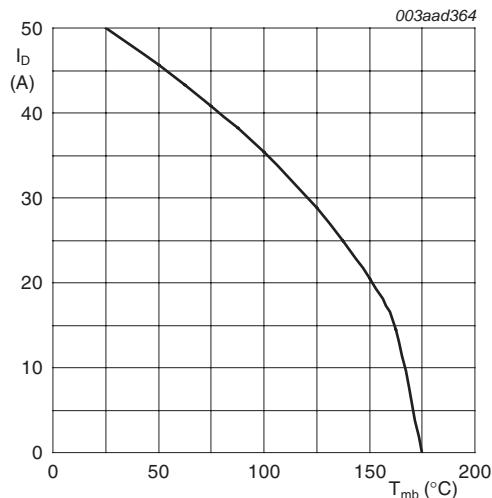
Type number	Package			
	Name	Description		Version
PSMN017-80PS	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78	

4. Limiting values

Table 4. Limiting values

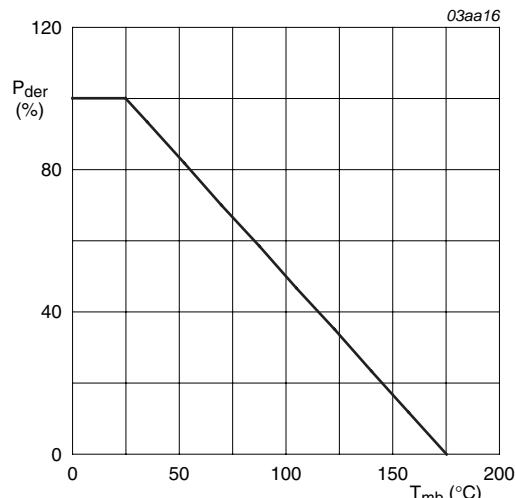
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25^\circ\text{C}; T_j \leq 175^\circ\text{C}$	-	80	V
V_{DGR}	drain-gate voltage	$T_j \geq 25^\circ\text{C}; T_j \leq 175^\circ\text{C}; R_{GS} = 20\text{ k}\Omega$	-	80	V
V_{GS}	gate-source voltage		-20	20	V
I_D	drain current	$V_{GS} = 10\text{ V}; T_{mb} = 100^\circ\text{C}$; see Figure 1	-	35	A
		$V_{GS} = 10\text{ V}; T_{mb} = 25^\circ\text{C}$; see Figure 1	-	50	A
I_{DM}	peak drain current	$t_p \leq 10\text{ }\mu\text{s}$; pulsed; $T_{mb} = 25^\circ\text{C}$; see Figure 3	-	200	A
P_{tot}	total power dissipation	$T_{mb} = 25^\circ\text{C}$; see Figure 2	-	103	W
T_{stg}	storage temperature		-55	175	°C
T_j	junction temperature		-55	175	°C
Source-drain diode					
I_S	source current	$T_{mb} = 25^\circ\text{C}$	-	50	A
I_{SM}	peak source current	$t_p \leq 10\text{ }\mu\text{s}$; pulsed; $T_{mb} = 25^\circ\text{C}$	-	200	A
Avalanche ruggedness					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	$V_{GS} = 10\text{ V}; T_{j(\text{init})} = 25^\circ\text{C}; I_D = 50\text{ A}; V_{sup} \leq 80\text{ V}; R_{GS} = 50\text{ }\Omega$; unclamped	-	55	mJ



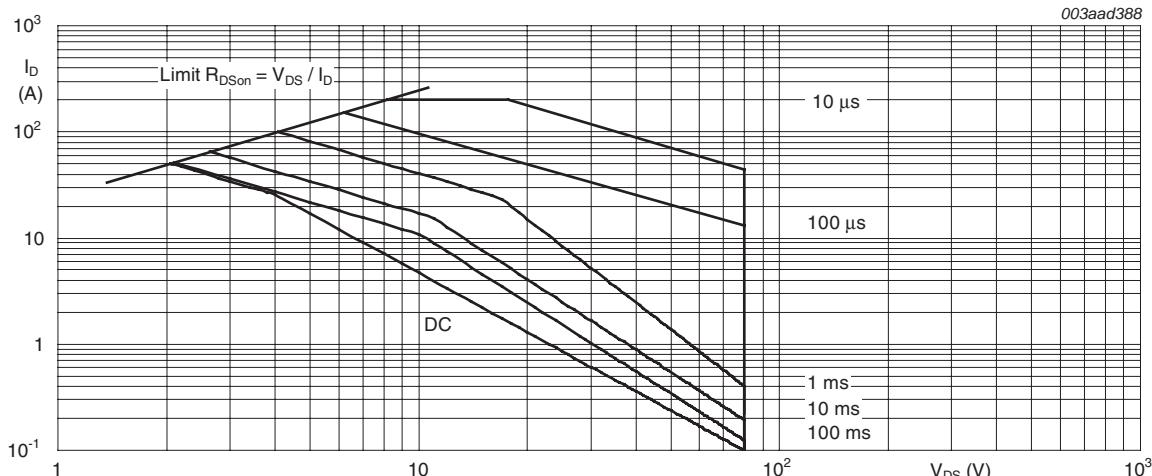
$V_{GS} \geq 10V$

Fig 1. Continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot}(25^{\circ}C)} \times 100\%$$

Fig 2. Normalized total power dissipation as a function of mounting base temperature



$V_{GS} \geq 10V$
(1) Capped at 100 A due to package.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j\text{-mb})}$	thermal resistance from junction to mounting base	see Figure 4	-	1	1.5	K/W

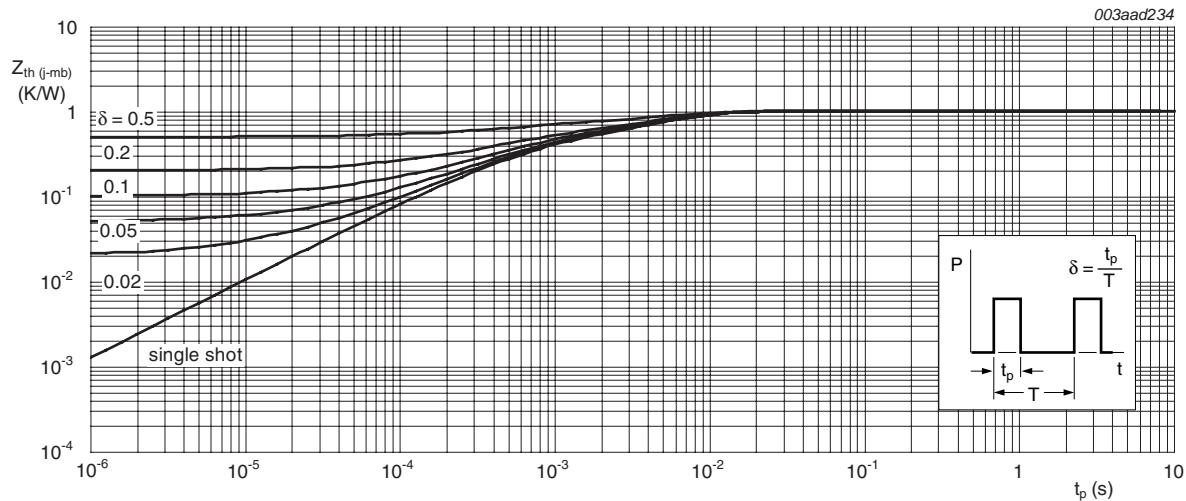


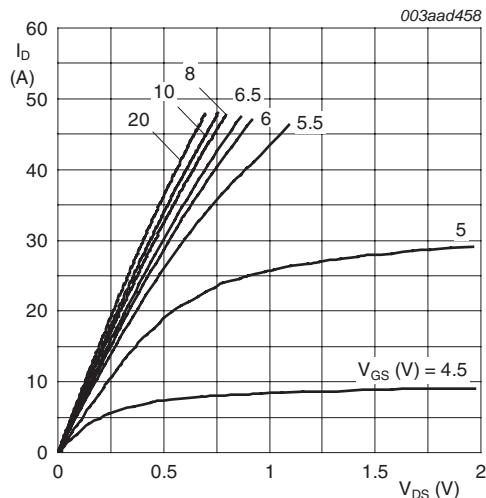
Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

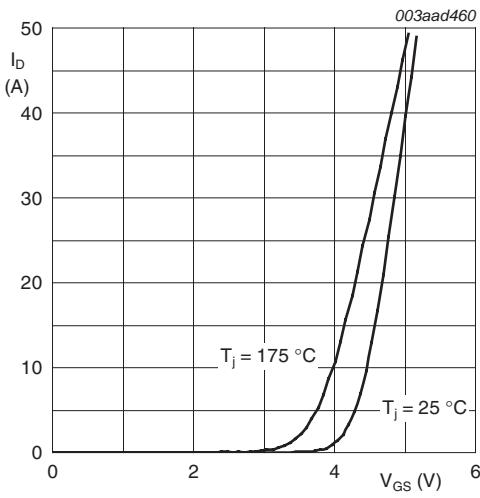
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55^\circ C$	72	-	-	V
		$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25^\circ C$	80	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 mA; V_{DS} = V_{GS}; T_j = 175^\circ C$; see Figure 10 and 11	1	-	-	V
		$I_D = 1 mA; V_{DS} = V_{GS}; T_j = -55^\circ C$; see Figure 10 and 11	-	-	4.8	V
		$I_D = 1 mA; V_{DS} = V_{GS}; T_j = 25^\circ C$; see Figure 10 and 11	2	3	4	V
I_{DSS}	drain leakage current	$V_{DS} = 80 V; V_{GS} = 0 V; T_j = 25^\circ C$	-	-	2	μA
		$V_{DS} = 80 V; V_{GS} = 0 V; T_j = 125^\circ C$	-	-	38	μA
I_{GSS}	gate leakage current	$V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25^\circ C$	-	1	100	nA
		$V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25^\circ C$	-	1	100	nA
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10 V; I_D = 10 A; T_j = 100^\circ C$; see Figure 12	-	-	29	mΩ
		$V_{GS} = 10 V; I_D = 10 A; T_j = 25^\circ C$; see Figure 13	-	13.7	17	mΩ
R_G	internal gate resistance (AC)	$f = 1 MHz$	-	1	-	Ω
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	$I_D = 0 A; V_{DS} = 0 V; V_{GS} = 10 V$	-	22	-	nC
		$I_D = 25 A; V_{DS} = 40 V; V_{GS} = 10 V$; see Figure 14 and 15	-	26.5	-	nC
Q_{GS}	gate-source charge	-	7.7	-	-	nC
$Q_{GS(th)}$	pre-threshold gate-source charge	-	4.6	-	-	nC
$Q_{GS(th-pl)}$	post-threshold gate-source charge	-	3	-	-	nC
Q_{GD}	gate-drain charge	-	6.3	-	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	$I_D = 25 A; V_{DS} = 40 V$; see Figure 15	-	4.7	-	V
C_{iss}	input capacitance	$V_{DS} = 40 V; V_{GS} = 0 V; f = 1 MHz; T_j = 25^\circ C$; see Figure 16	-	1573	-	pF
C_{oss}	output capacitance	-	154	-	-	pF
C_{rss}	reverse transfer capacitance	-	88	-	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = 40 V; R_L = 1.6 \Omega; V_{GS} = 10 V$	-	14.3	-	ns
t_r	rise time	$R_{G(ext)} = 4.7 \Omega$	-	12.3	-	ns
$t_{d(off)}$	turn-off delay time	-	27	-	-	ns
t_f	fall time	-	7.7	-	-	ns
Source-drain diode						
V_{SD}	source-drain voltage	$I_S = 25 A; V_{GS} = 0 V; T_j = 25^\circ C$; see Figure 17	-	0.8	1.2	V
t_{rr}	reverse recovery time	$I_S = 50 A; dI_S/dt = 100 A/\mu s; V_{GS} = 0 V$	-	41.6	-	ns
Q_r	recovered charge	$V_{DS} = 40 V$	-	55.5	-	nC

[1] Tested to JEDEC standards where applicable.



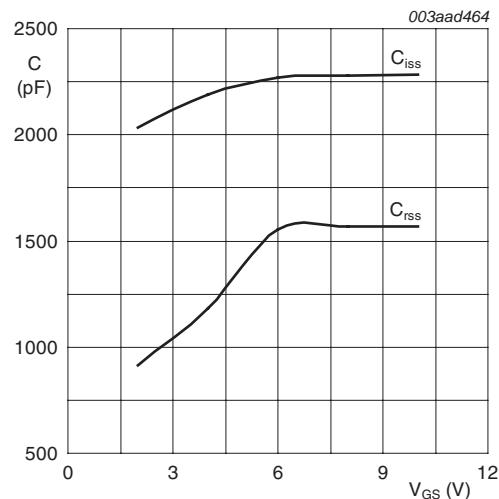
$T_j = 25^\circ\text{C}$; $t_p = 300\ \mu\text{s}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



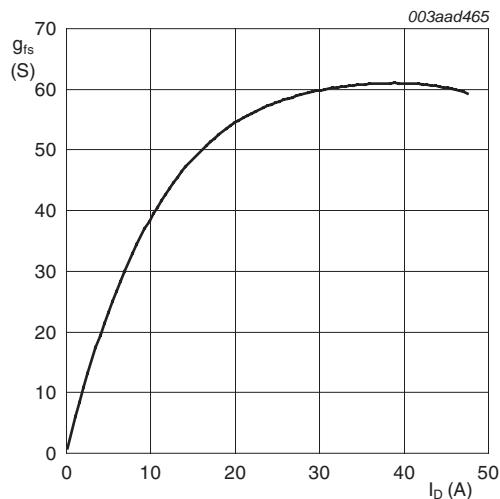
$V_{DS} = 15\text{V}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values



$V_{DS} = 0\text{V}$; $f = 1\text{MHz}$

Fig 7. Input and reverse transfer capacitances as a function of gate-source voltage; typical values



$T_j = 25^\circ\text{C}$; $V_{DS} = 15\text{V}$

Fig 8. Forward transconductance as a function of drain current; typical values

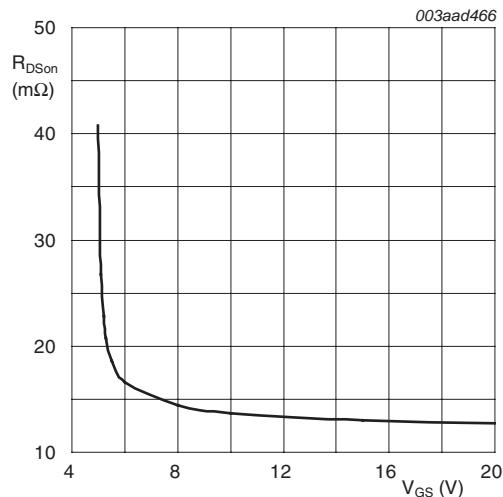

 $T_j = 25^\circ C; I_D = 25 A$

Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values

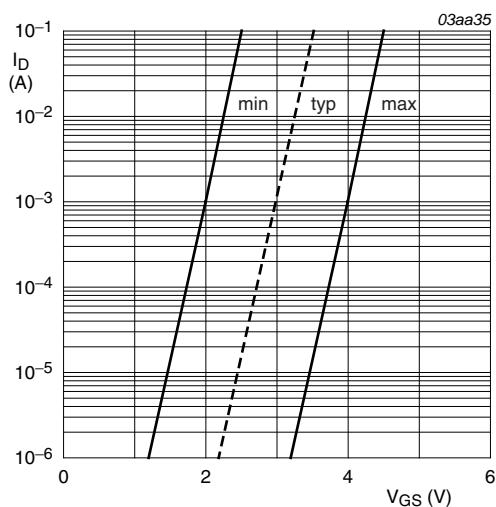

 $T_j = 25^\circ C; V_{DS} = 5 V$

Fig 10. Sub-threshold drain current as a function of gate-source voltage

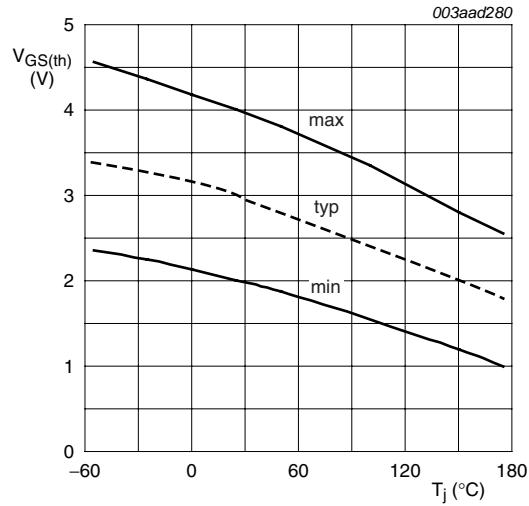
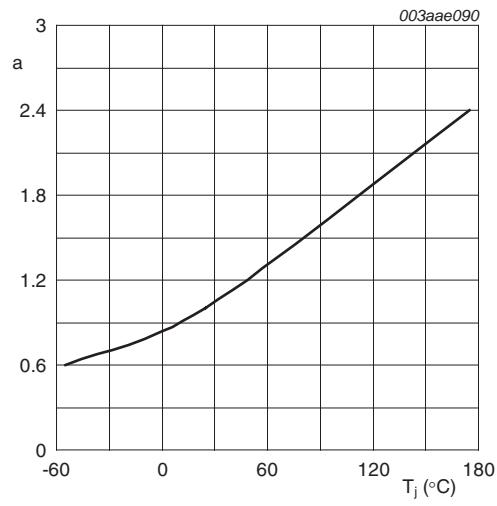
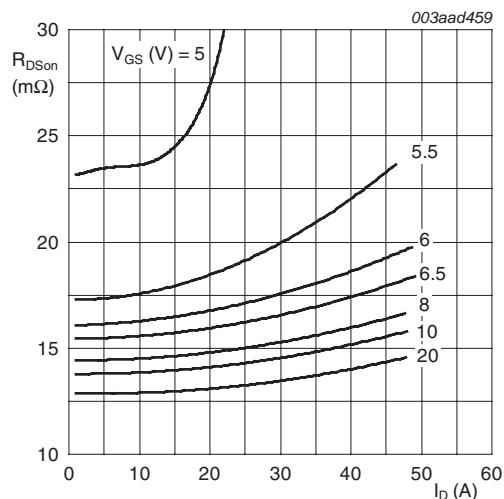

 $I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 11. Gate-source threshold voltage as a function of junction temperature



$$a = \frac{R_{DS(on)}}{R_{DS(on)(25^\circ C)}}$$

Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature



$T_j = 25^\circ C; t_p = 300 \mu s$

Fig 13. Drain-source on-state resistance as a function of drain current; typical values

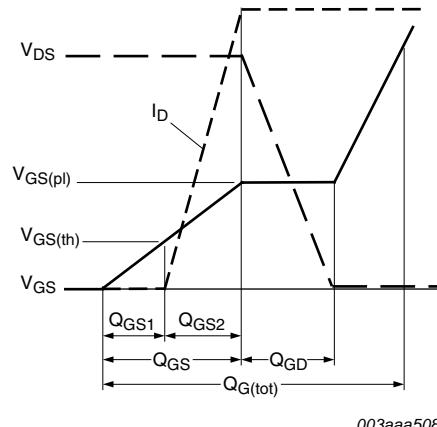
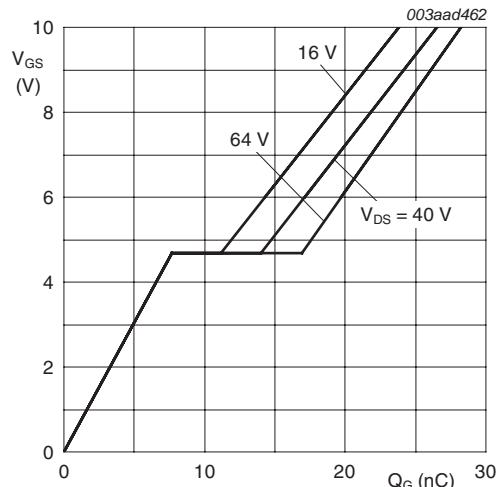
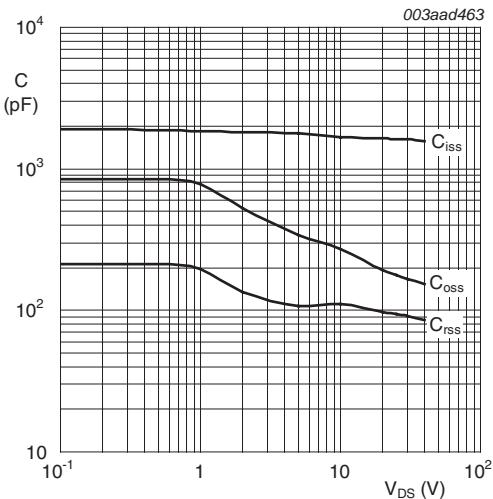


Fig 14. Gate charge waveform definitions



$T_j = 25^\circ C; I_D = 25 A$

Fig 15. Gate-source voltage as a function of gate charge; typical values



$V_{GS} = 0 V; f = 1 MHz$

Fig 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

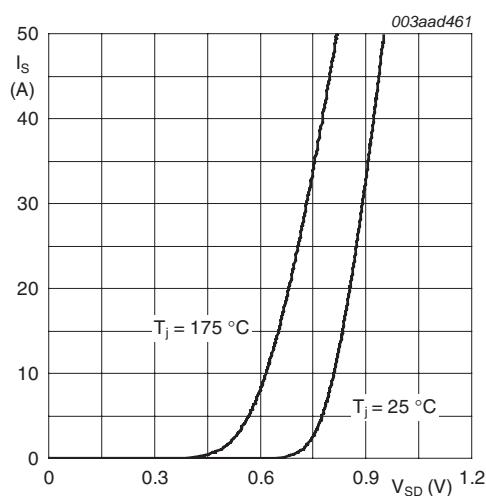
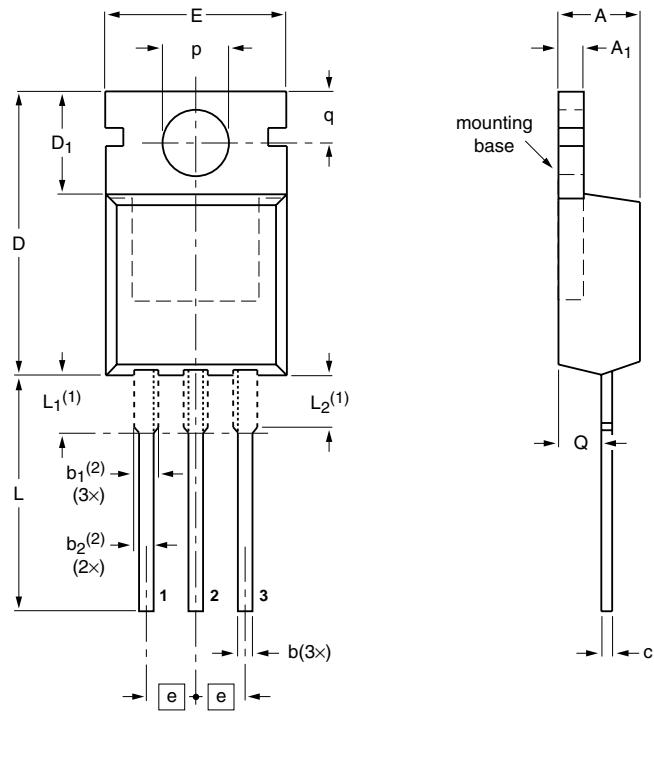
 $V_{GS} = 0\text{ V}$

Fig 17. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78



DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁	b	b ₁ ⁽²⁾	b ₂ ⁽²⁾	c	D	D ₁	E	e	L	L ₁ ⁽¹⁾	L ₂ ⁽¹⁾ max.	p	q	Q
mm	4.7	1.40	0.9	1.6	1.3	0.7	16.0	6.6	10.3	2.54	15.0	3.30	3.0	3.8	3.0	2.6
	4.1	1.25	0.6	1.0	1.0	0.4	15.2	5.9	9.7	12.8	2.79	3.0	3.5	2.7	2.7	2.2

Notes

1. Lead shoulder designs may vary.
2. Dimension includes excess dambar.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT78		3-lead TO-220AB	SC-46			08-04-23 08-06-13

Fig 18. Package outline SOT78 (TO-220AB)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN017-80PS_1	20100311	Objective data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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